

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10840089	TIN, SIU-KEI
	<b>Examiner</b>	<b>Art Unit</b>
	YUZHEN GE	2624

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
updated	the previous search	10/16/2008	YG
Updated	the previous search	2/25/2009	YG

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
Updated the previous search	10/16/2008	YG
Updated the previous search	2/25/2009	YG

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>

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